

2016年度

量子ビームサイエンスフェスタ

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弊社は茨城県ひたちなか市に拠点を置き
放射線・物理計測用モジュールや検出器など
自社で設計・開発・製造・販売する
国内でも数少ない精密測定機器メーカーです。

放射光施設や放射線に関連した研究を行う
大学や施設などから数多くの引き合いを頂いており
市場のニーズを反映した新製品の開発や
さまざまな課題に対し積極的に取り組んでおります。

4element SDD for X-ray

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XSDD50-04-25

**JAPAN
MADE**

For Soft X-ray

*Measurable from low energy
region to hundreds of eV*

Window-less

NEW



Count Rate

1Mcps or more

65mm² collimated to 50mm²



Surface of Detector
Angle degrees 25

Energy Resolution

- 244eV@5.9keV Mn Ka
Peaking Time: 0.25 μ s
- 130eV@5.9keV Mn Ka
Peaking Time: 1 μ s

4element SDD system for X-ray

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XSD50-04-25

**JAPAN
MADE**



検出器
背面部分



NEW

Function

- Histogram
- List-mode
- Wave
- **FAST Output**
- **ROI-SCA Output**
- **Quick-Scan**

Data measurement device

APU504GbE

4CH 100Msps 14bit



APU504GbE

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4CH 100Msps 14bit

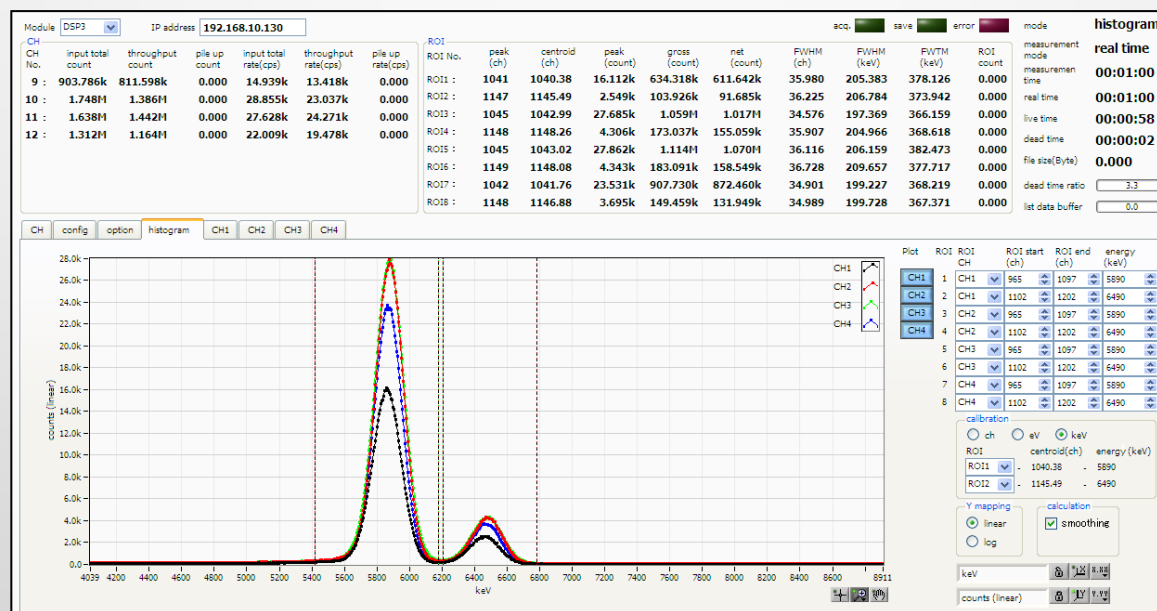


Quick-Scanモードとは、時間分解測定を行うもので外部トリガタイミング（最小10ms）間隔でその間のヒストグラムデータをPC側に送信し、PC側で連続してHDDにデータを保存するモードです。

QXAFS測定に最適です。

Quick-Scanデータ例

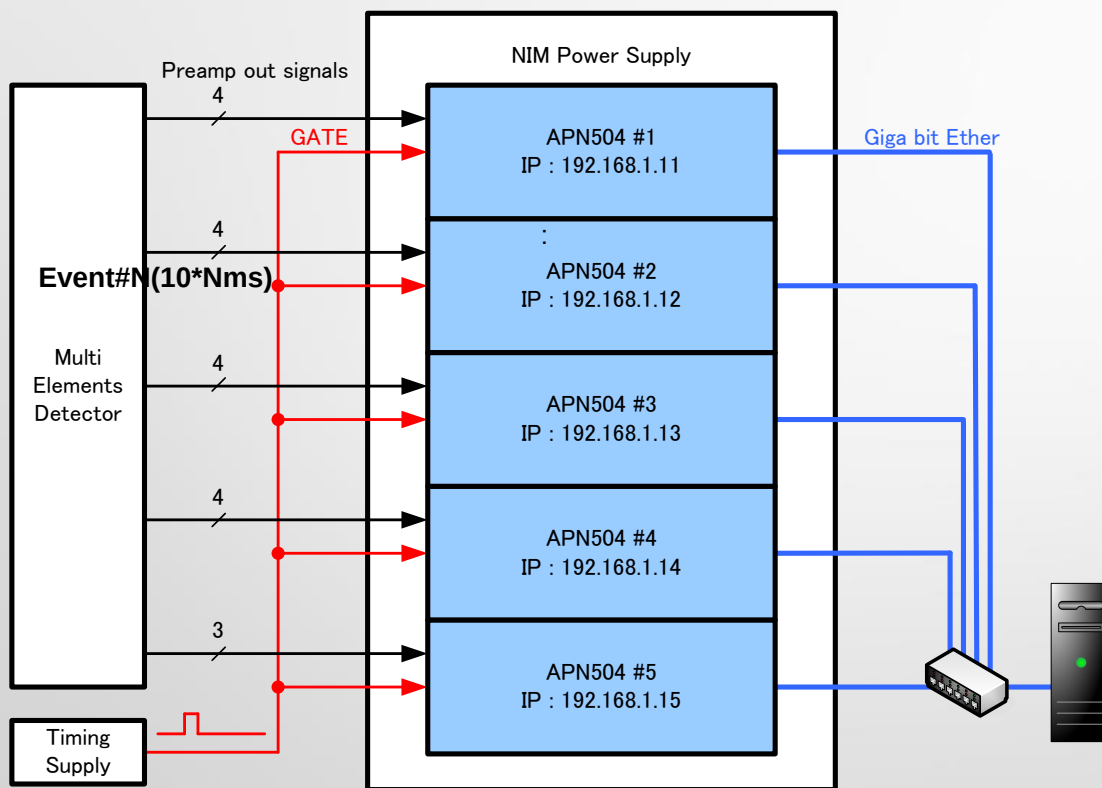
Event#1	CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch
Event#2	CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch
⋮				
Event#N	CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch



データ収集用アプリケーション画面
(185eV@5.9keV ピーキングタイム0.25μs)

APN504X GbE for Quick XAFS

- Quick scan **10ms(min.) interval**
4096ch * 16bit * 4CH / Event
- Interface Giga bit Ether TCP/IP and UDP



APN504XGbE

APN504X GbE for Quick XAFS

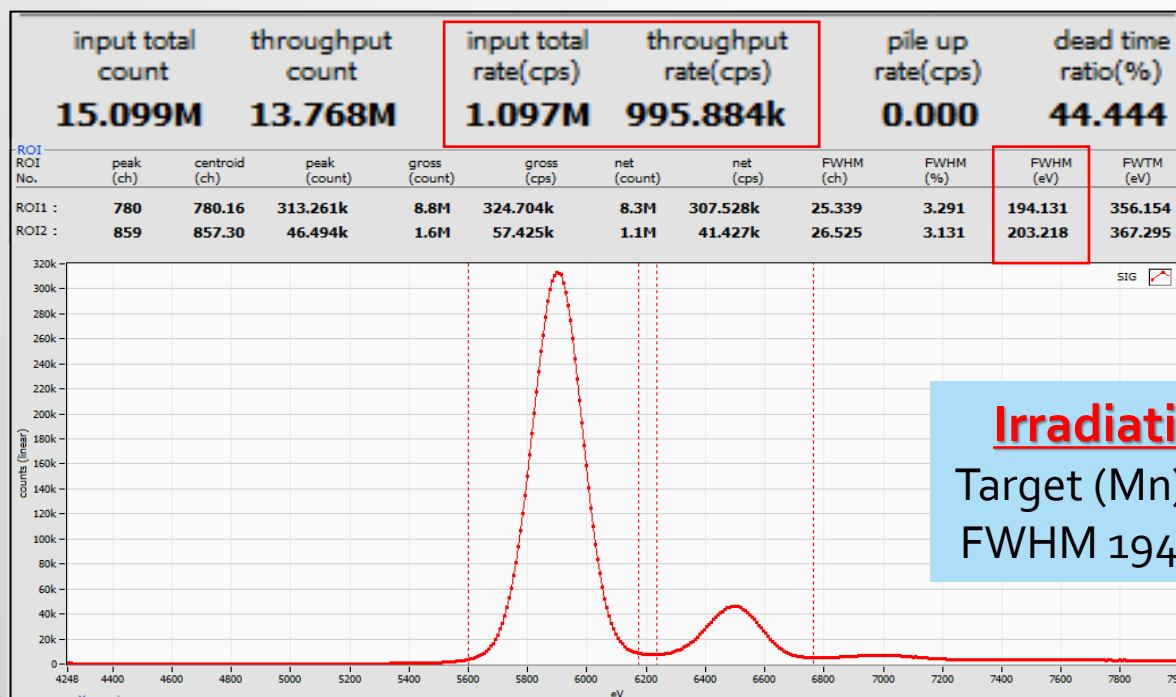
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● Data format

Event#1(10ms)

CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch
CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch
CH1 4096ch	CH2 4096ch	CH3 4096ch	CH4 4096ch

Event#2(20ms)



Irradiation Test on Synchrotron

Target (Mn), ICR 1.1Mcps, OCR 1.0Mcps, FWHM 194eV@5.9keV MnK α 0.15 μ sPT

7 element SDD system for fluorescence X-ray

- Element area
 455mm^2 ($65\text{mm}^2 \times 7$ elements)
- Effective area
 350mm^2 (65mm^2 Collimated to $50\text{mm}^2 \times 7$ elements)
- Function
Histogram, List, Waveform, ROI-SCA
- ADC
4CH 100Msps 14bit
- Energy Resolution
 **$244\text{eV}@5.9\text{keV MnK } \alpha$
Peaking time $0.25\mu\text{s}$, 1000kOCR**
- Power Supply for SDD
 -200V , $\pm 5\text{V}$, $+3.3\text{V}$
- Interface
Ethernet (TCP/IP)

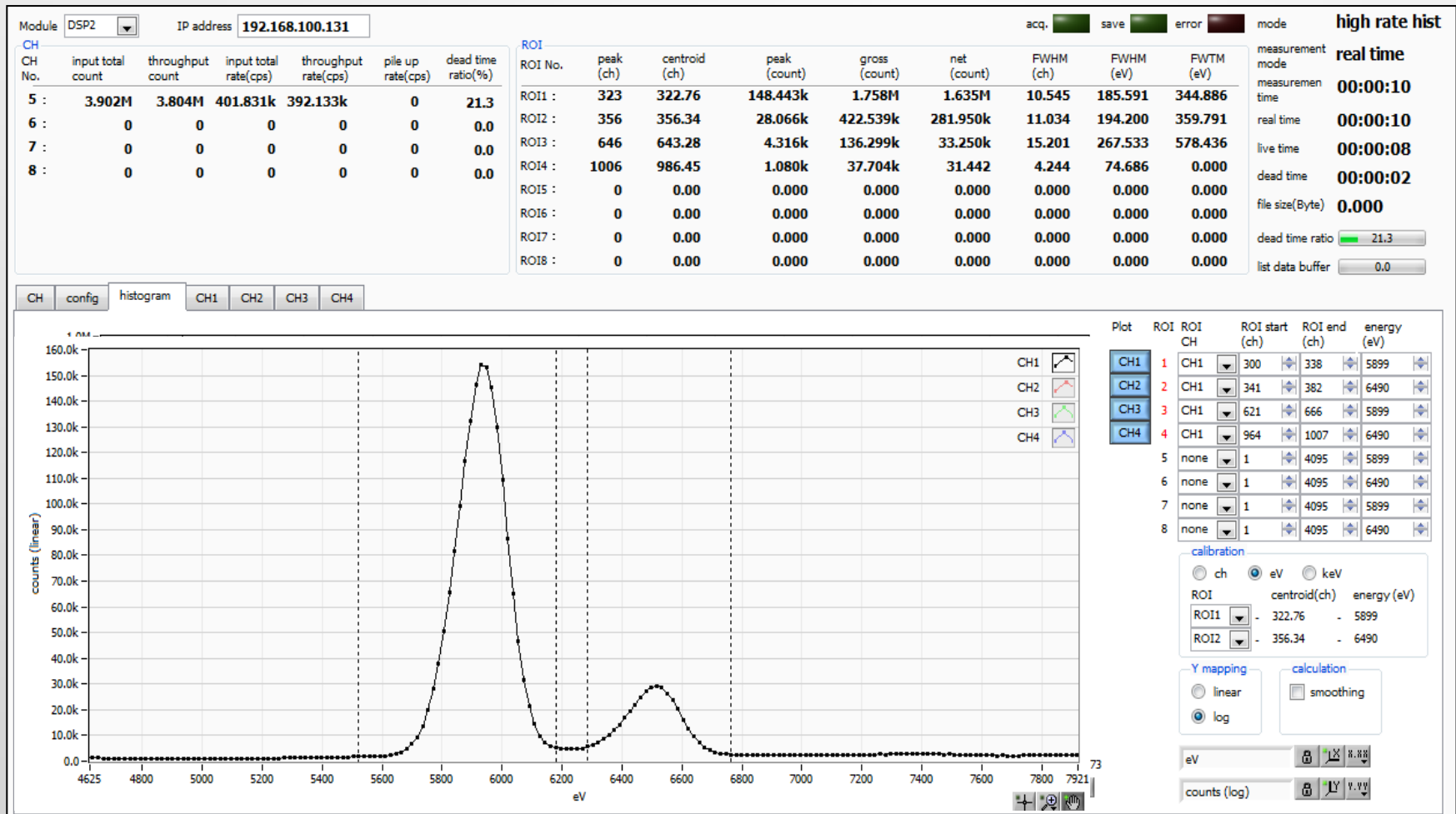


XSDD50-07

DSP modules & Power supply

7 element SDD system for fluorescence X-ray

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400k ICR 185eV@5.9keV, Peaking Time 0.25μs

Digital Signal Processing for X-ray

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- Energy resolution
[SSD with 19 elements]
139eV@5.9keV, 6 μ s Peaking Time
144eV@5.9keV, 4 μ s Peaking Time
250eV@5.9keV, 0.25 μ s Peaking Time
[SDD]
125eV@5.9keV, 2 μ s Peaking Time
- Throughput
Over 1Mcps
- Mode
Histogram, List
- Option
TTL output of ROI-SCA



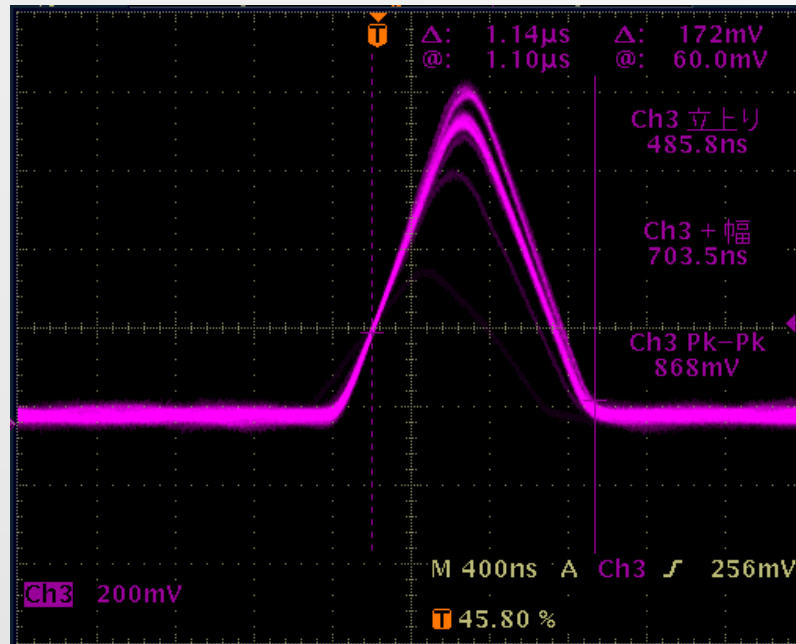
Measurements boards
for 19 elements of SSD



APV8004X

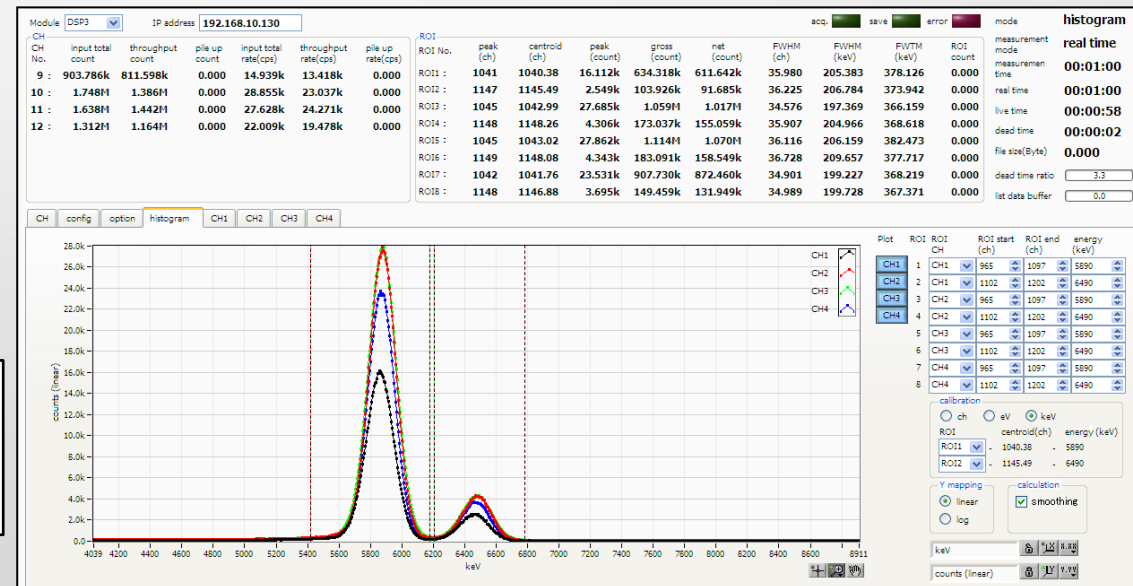
Digital Signal Processing for X-ray

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Trapezoidal filter

Screenshot
of Application



APV8016 Digital Signal Processor

TechnoAP

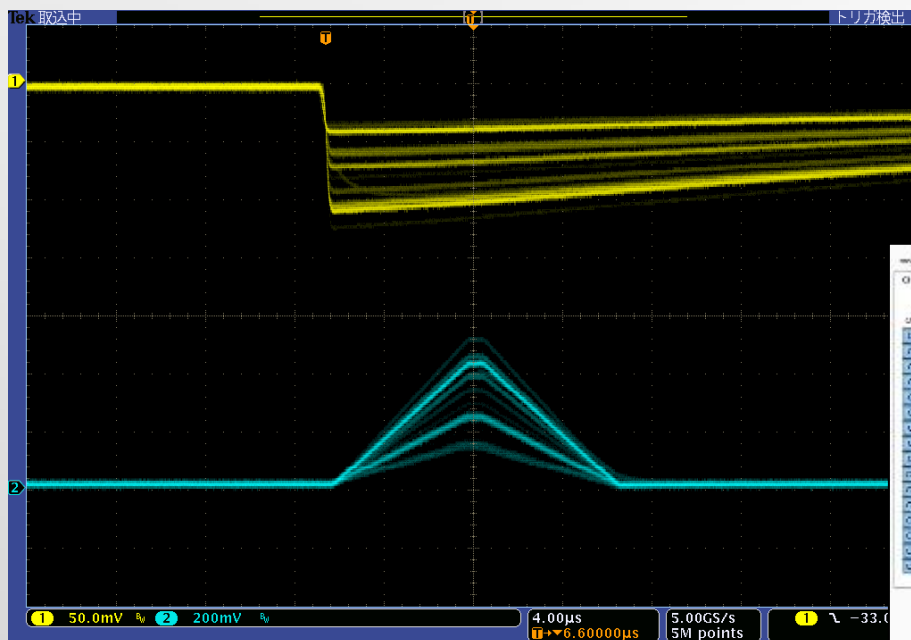
Analog Input	16CH, Input Impedance 1k Ω , LEMOoo series connector
ADC	Sampling 100MSPS, Resolution 14bit, Input range $\pm 1V$
Coarse Gain	x2, x4, x10, x20 *Setting by PC
Fine Gain	x0.5~x1.5 *Setting by PC
ADC GAIN	8K, 4K, 2K, 1K, 512, 256ch
Trapezoidal Filter	0.1~12 μs (0.01step)
Digital Signal Processing	Baseline Restorer, Pileup Rejecter, and CFD etc. All parameter can set by PC.
External terminal	Output filter waveform, Input clock, Input GATE, Input VETO, Input clear, 2 CH for function enhancement
Interface	TCP/IP or UDP, 100BaseT
External dimensions	VME6U 20(W) x262(H) x187(D) Unit 300(W) x56(H) x335(D)
Total weight	VME6U About 470g Unit About 3300g



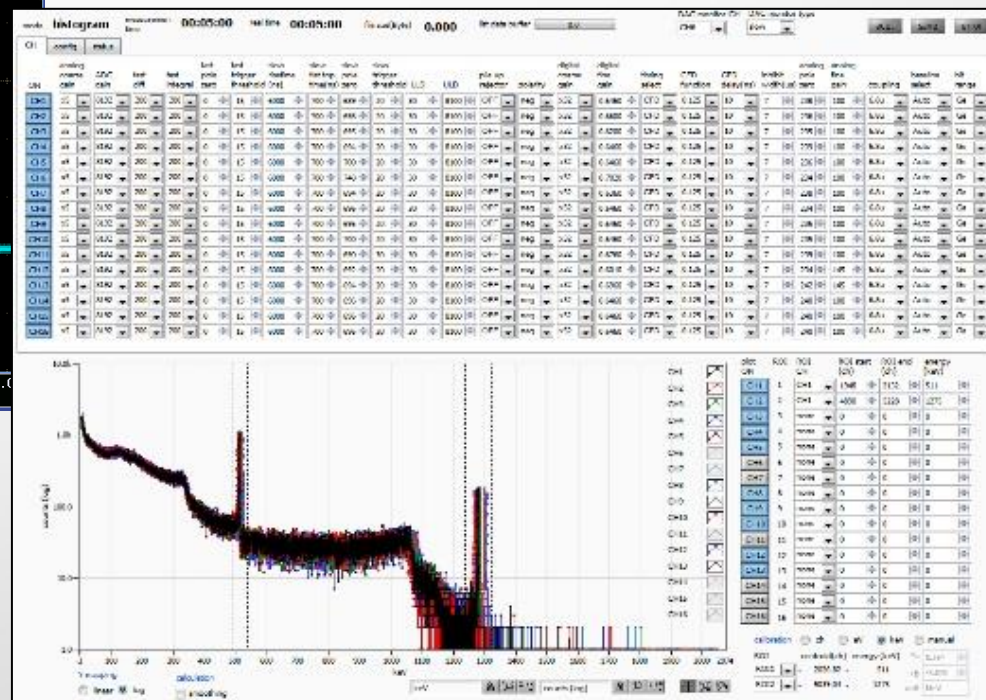
APV8016

APV8016 Digital Signal Processor

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Application
Histogram Mode



Outputted DAC
Upper : Preamp
Lower: Trapezoidal Filter

APV8016 Digital Signal Processor

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◆ Resolution

[Energy] 1.70 keV @ 1.33 MeV,
[Time] Resolution 0.625 ns (minimum unit)

◆ Throughput

100kcps and over

◆ Mode

Histogram, List, Waveform
Maximum transfer rate of the List mode 160Kcps (using 1 CH)

◆ Multifunction

Spectroscopy amp, Timing filter amp, CFD,
Input and Filter waveform output DAC

◆ Option

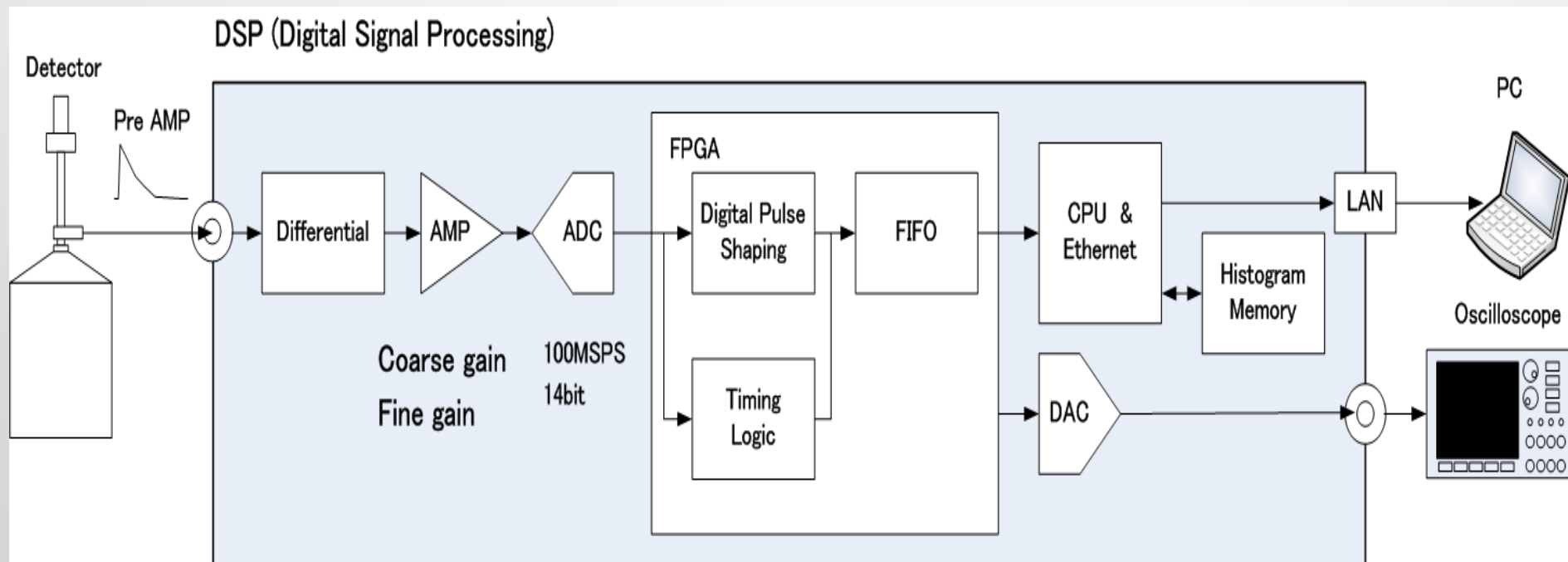
Coincidence, Rise Wave

◆ Software

Application and Instruction manual of Hard and Software

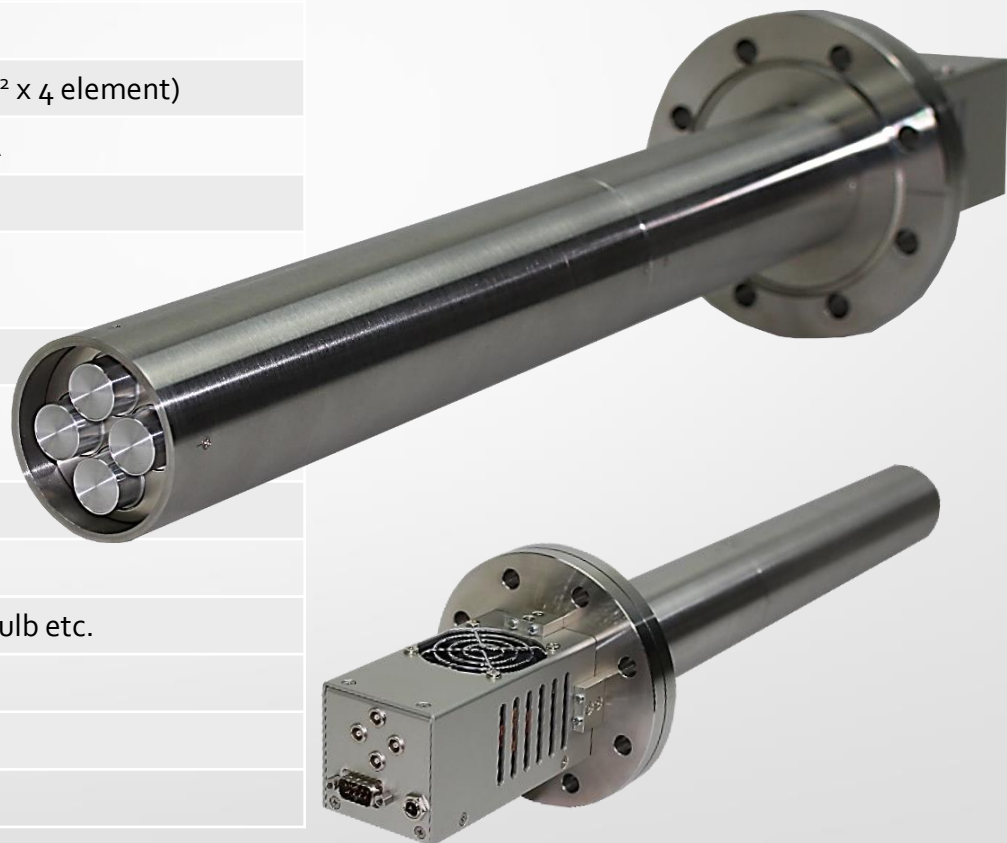
APV8016 Digital Signal Processor

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4element SDD for X-ray

Detector	SDD detector 50mm ² , Window-less or AP _{3.3}
All element area	260mm ² (65mm ² x 4 element)
Active area	200mm ² (65mm ² collimated to 50mm ² x 4 element)
Function	Histogram, List, Waveform, ROI-SCA
ADC Sampling	4CH 100MSPS 14bit
Energy Resolution	244eV@5.9keV MnK α (Peaking time 0.25 μ s, 1000kOCR)
SDD Power	-200V, ± 5 V, +3.3V
Throughput	Max 150kcps: 2 μ s Peaking time Max 1000kcps: 0.15 μ s Peaking time
Interface	Ethernet (TCP/IP)
Power Supply	NIM-BIN Support, VME Power Supply
Option	Z-axis movement mechanism, UHV bulb etc.
Vacuum capable	<10 ⁻³ Pa
Flange type	ICF114
Accessory	Application and Manual



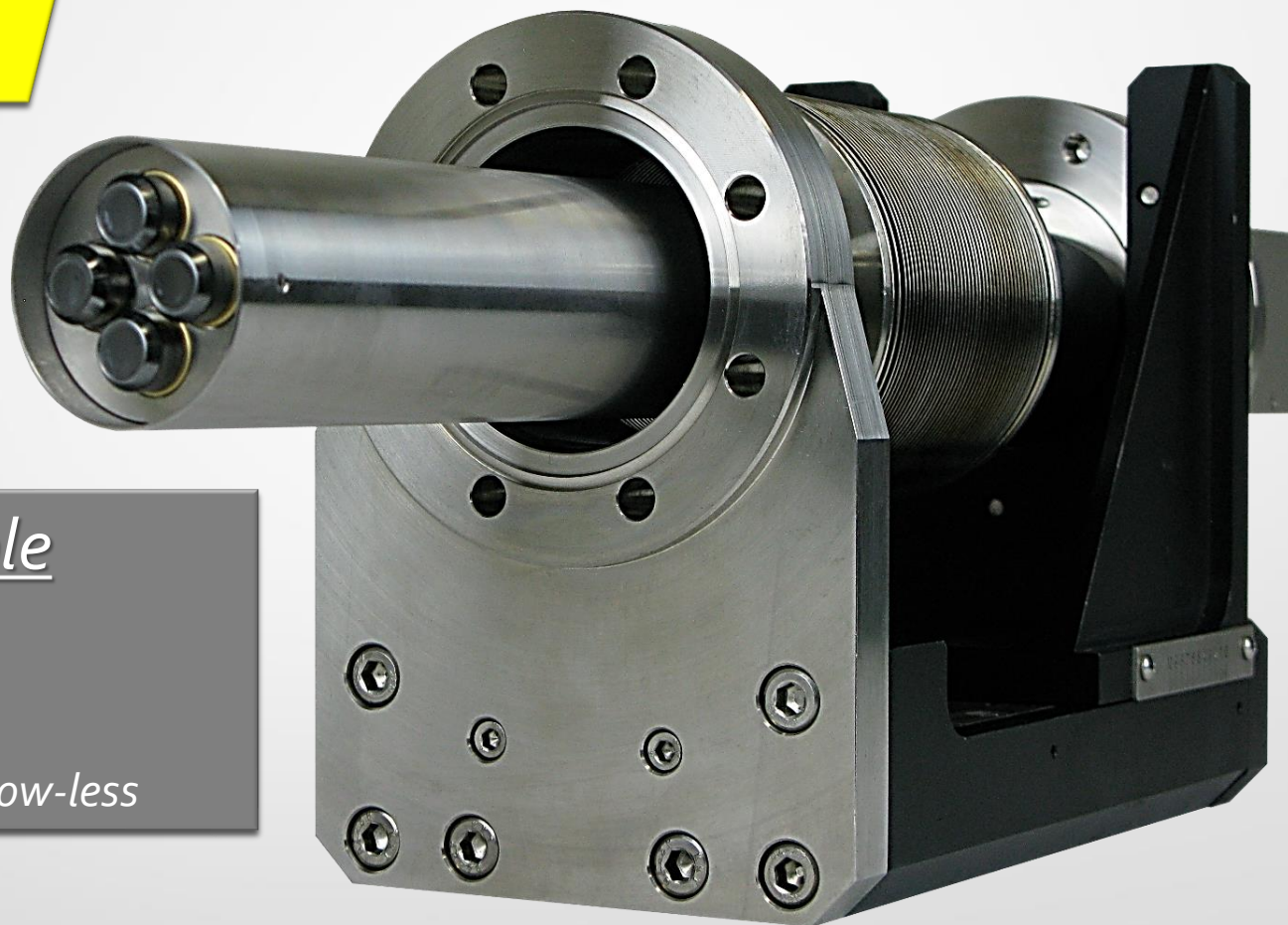
XSD50-04

4element SDD for X-ray

XSDD50-04

Detector selectable

- Active Area
30mm² or 50mm²
- Window
Be, AP3.3, Window-less

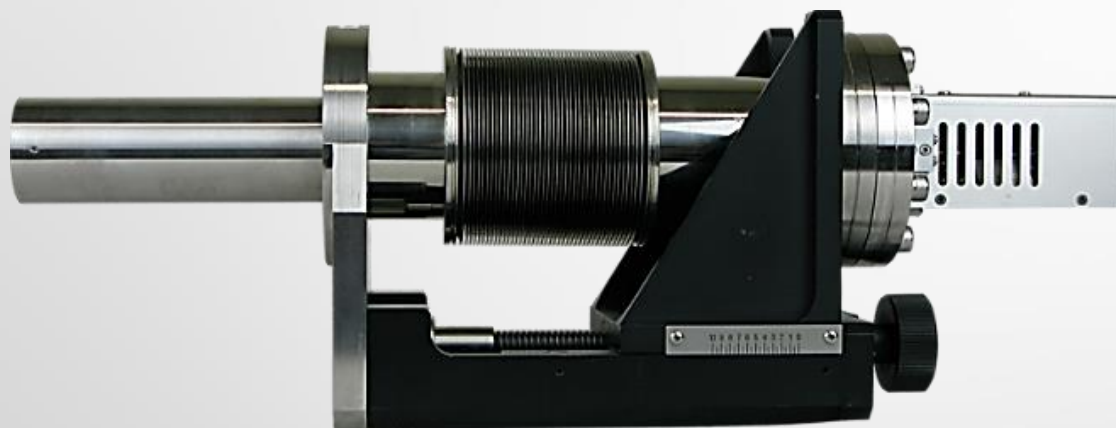


【Use cases】

Transport with bellows corresponding to the vacuum

4element SDD for X-ray

XSDD50-04



【Use cases】

Transport with bellows corresponding to the vacuum

Recommendable Measurement
Module

APN504XGbE

High-Speed ADC

(100MHz • 14Bit)

Digital signal processing by

Highly-integrated FPGA

Measurement Data

- Histogram
- List
- Quick Scan



Single element SDD for X-ray

Detector	SDD detector 50mm ² , Window-less or AP _{3.3}
Element Area	65mm ²
Active Area	65mm ² collimated to 50mm ²
Function	Histogram, List, Waveform, ROI-SCA
ADC Sampling	100MSPS 14bit
Energy Resolution	125eV@5.9keV 2us Peaking time 150eV@5.9keV 0.15us Peaking time
SDD Power	-200V, $\pm 5V$, +3.3V
Throughput	Max 150kcps: 2us Peaking time Max 1000kcps: 0.15us Peaking time
Interface	Ethernet (TCP/IP)
Power Supply	NIM-BIN Support, VME Power Supply
Option	Z-axis movement mechanism, UHV bulb etc.
Vacuum capable	<10 ⁻³ Pa
Flange type	ICF70
Accessory	Application and Manual

**XSD50-01WL**

Single element SDD for X-ray

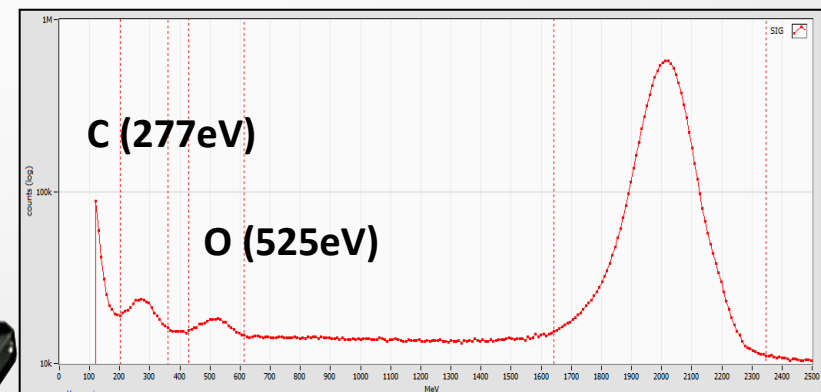
XSDD50-01WL

Detector selectable

- Active Area
30mm² or 50mm²
- Window
Be, AP3.3, Window-less



Spectrum of Soft X-ray

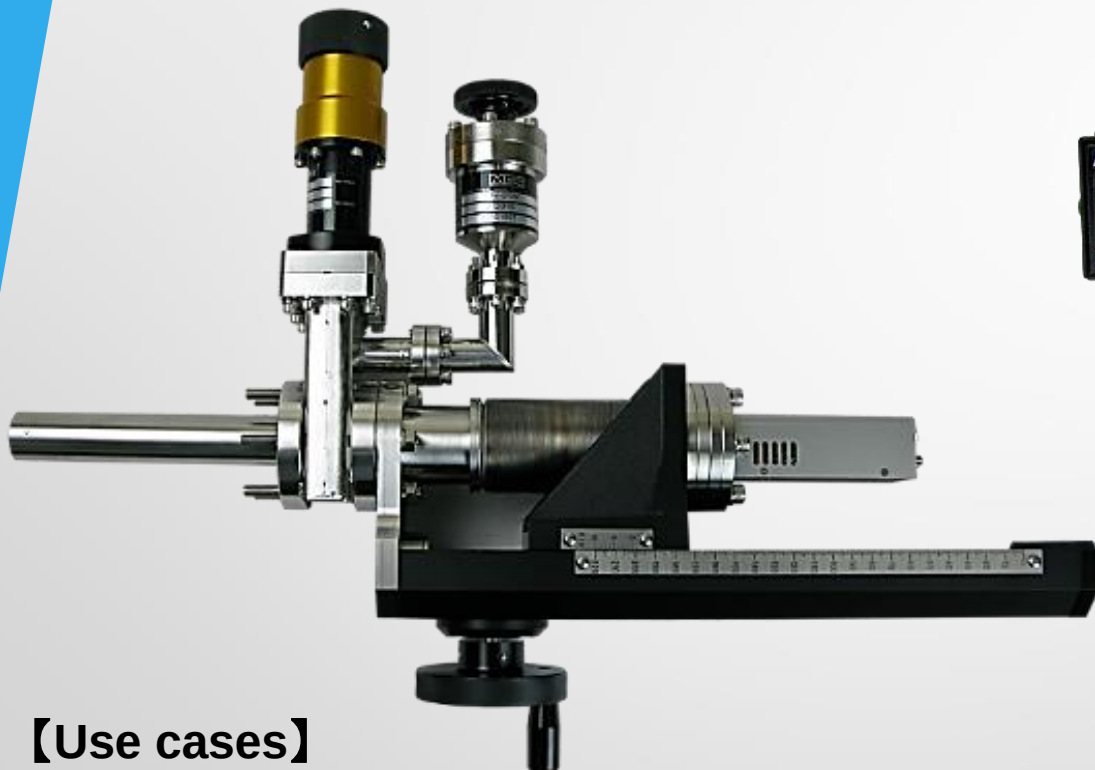


【Use cases】

Gate valve and Angle valve Transport
with bellows corresponding to the vacuum

Single element SDD for X-ray

XSDD50-01WL



【Use cases】

Gate valve and Angle valve Transport
with bellows corresponding to the vacuum



*Recommendable
Measurement Module*

APU101X

DIGITAL SPECTROSCOPY

within

- *1CH HV Power Supply*
- *Pre-amp Power*
- *MCA*

APU101 X-ray spectra meter

- Detector type
SDD, SSD
- Throughput
Over 1Mcps
- Power supply
HV(+/-4000V), Preamp
- Energy resolution
[SSD]
139eV@5.9keV PT6 μ s
250eV@5.9keV PTo.5 μ s
[SDD]
125eV@5.9keV PT2 μ s
145eV@5.9keV PTo.5 μ s
- Interface
TCP/IP



Front



Rear

APU101

APN101X X-ray spectra meter

- Detector type
SDD, SSD
- Throughput
Over 1Mcps
- Power supply
HV(+/-4000V), Preamp
- Energy resolution
[SSD]
139eV@5.9keV PT6us
250eV@5.9keV PTo.5us
[SDD]
125eV@5.9keV PT2μs
145eV@5.9keV PTo.5μs
- Interface
TCP/IP



APN101X

APV8102-14 MWPSAGb

- ◆ ADC

2CH, 14bit, 1GHz Synchronism Sampling

- ◆ Memory

1GB (512MB+512MB) × 2

- ◆ Time Resolution

Coarse: 2ns | Fine: 7.8ps

- ◆ Throughput

1Mcps or more / CH

- ◆ Analyze Mode

Waveform acquisition, List (TDC+QDC etc.)

- ◆ Analyze Functions

(Digital) CFD, TDC, DC, PSA etc.

- ◆ Interface

1000BASE-T (over 1M List event)



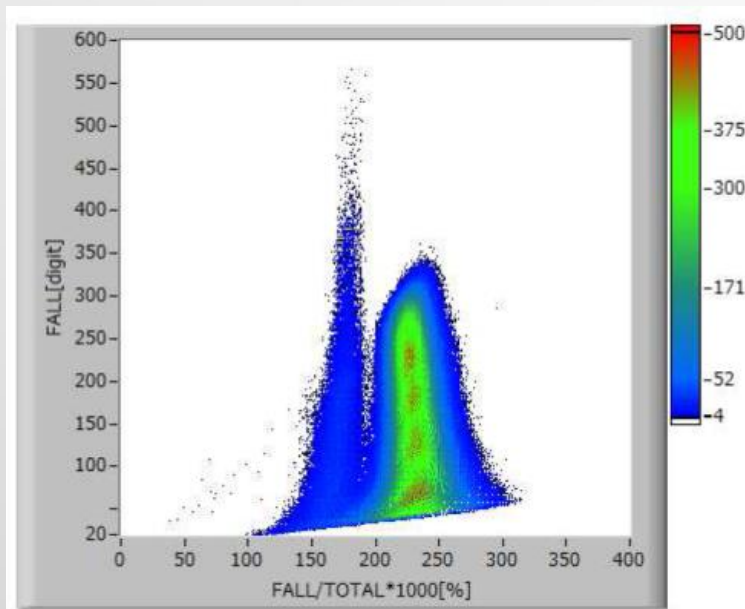
APV8102-14

APV8102-14 MWPSAGb

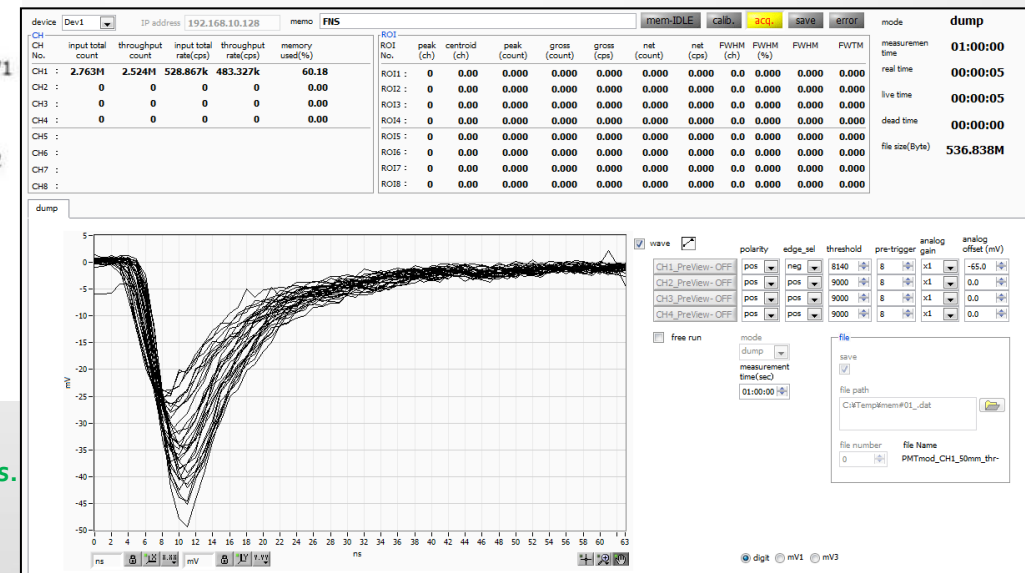
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Discrimination of γ and neutron

(Vertical axis: Waveform fall time integral calculus level
Horizontal axis: Fall time integral calculus level
/ All waveform integral calculus level)



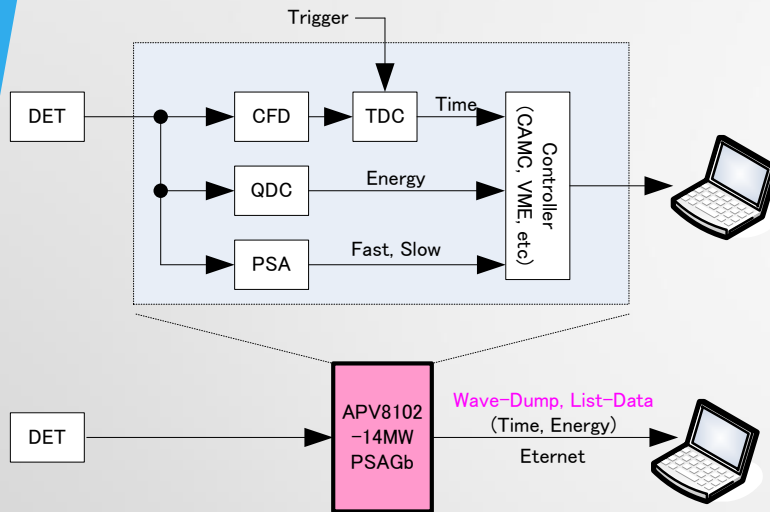
*Capable number of channel change may occur due to the signal processing custom and selected options.



Application Waveform acquisition

APV8102-14 MWPSAGb

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Unified functions of each modules

Analog signal input type	PMT anode signal, Fast-NIM signal etc.
Analog signal input range	$\pm 3V$ (Z_{in} :50 Ω , GAIN x 1) (LEMO connector x 2) *Customizable maximum $\pm 4V$ capable
Analog offset adjustment	$\pm 2V$ (12bit) *Customizable $\pm 20mV$ to $\pm 4V$ capable
Analog gain switch	X 1 / x 3 *Customizable under input range limit x 10 capable
Analog signal rise time	Under 1ns (@Gain x 1)
Outside in/output signal terminal (TTL level)	CLK input, CLK output, GATE input, VETO input CLR input, OR output (LEMO connector x 6) *Customizable switch in/output signal
Interface	Ethernet (TCP/IP) 1000BASE-T
Dimension and Weight	VME1width 20mm(W) x 262mm(H) x 187mm(D), 540g
Environmental conditions	Temperature 5 to 25°C
Electricity consumption	+5V(2.5A), +12V(0.6A), -12V(0.3A)
Accessory	Application and Manual

USB-MCA₄

USB bus power, List of 4CH corresponding MCA

- Channel
4CH
- Static Dead Time
1.5μs
- Throughput
50kcps and more
- ADC Gain
16384, 8192, 4096, 2048, 1024, 512ch
- Mode
Spectrum, List
- Power
USB bus power
- Body
Lightweight, Compact aluminum case
- Interface
USB2.0
- Data transfer
List data 100kcps/sec and more
- Software
Driver & Application



APG7400A

USB-MCA4

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General configuration example



LIST Data

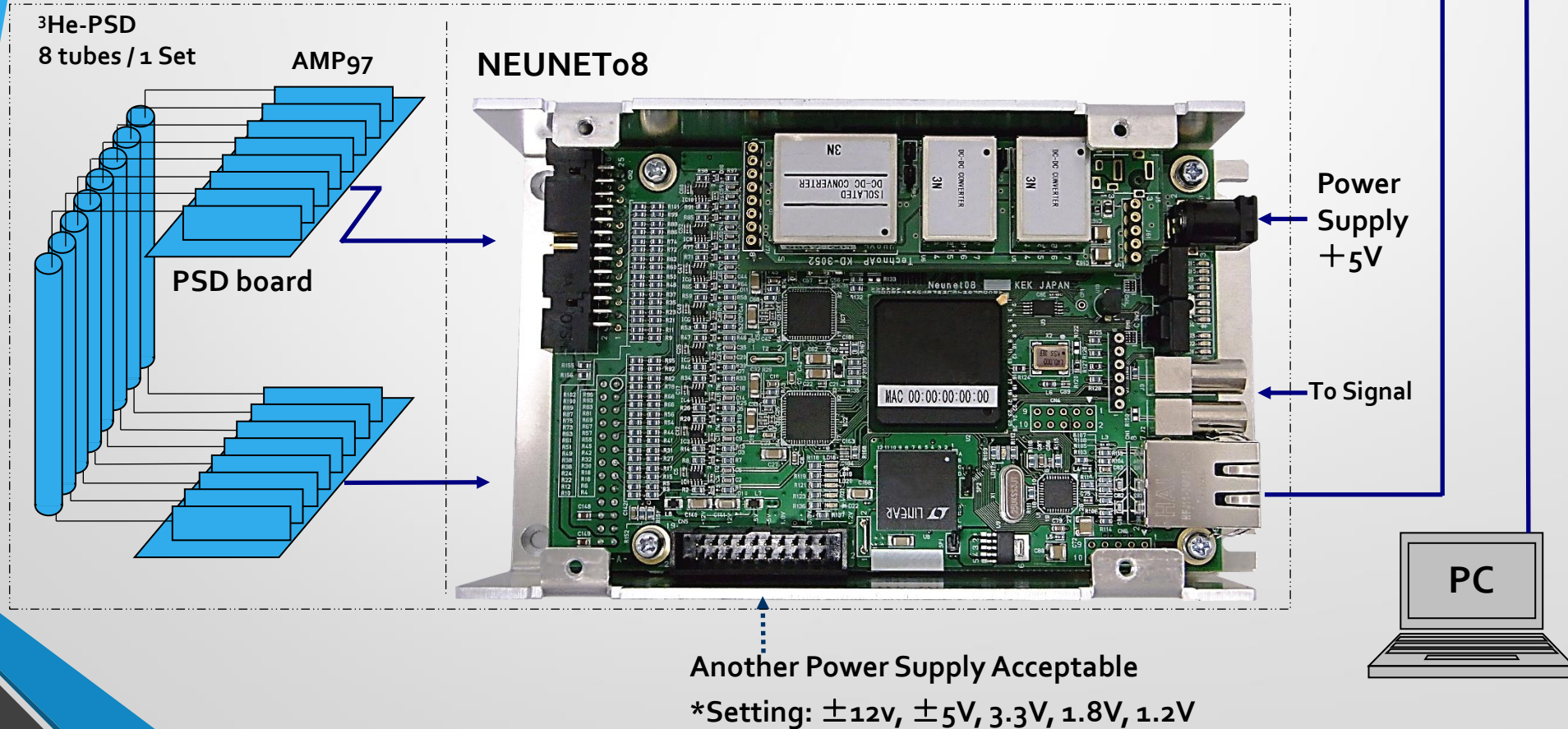
Event #1	Empty(4bit)	Time(44bit)	CH(2bit)	PHA(14bit)
Event #2	Empty(4bit)	Time(44bit)	CH(2bit)	PHA(14bit)
:				
Event #N	Empty(4bit)	Time(44bit)	CH(2bit)	PHA(14bit)

* Data Size 8Byte/Event, Time 40ns/bit

KD-3052 PSD System

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^3He -PSD System



KD-3052 PSD System

High Energy Accelerator Research Organization developed this board.

This is based on technical specification [KENS-DAQ-012]

which Bee Beans Technologies (BBT) Co., Ltd. shows.

We have a regular license from BBT and produce it.

The neutron scientific facilities (KENS) of High Energy Accelerator Research Organization develop an experiment to realize structure analysis and this of the material as one of the neutron dispersion studies and a measuring system.

This measuring system is called **NEUNET** system
(Neutron Position Sensitive Model Detector System).

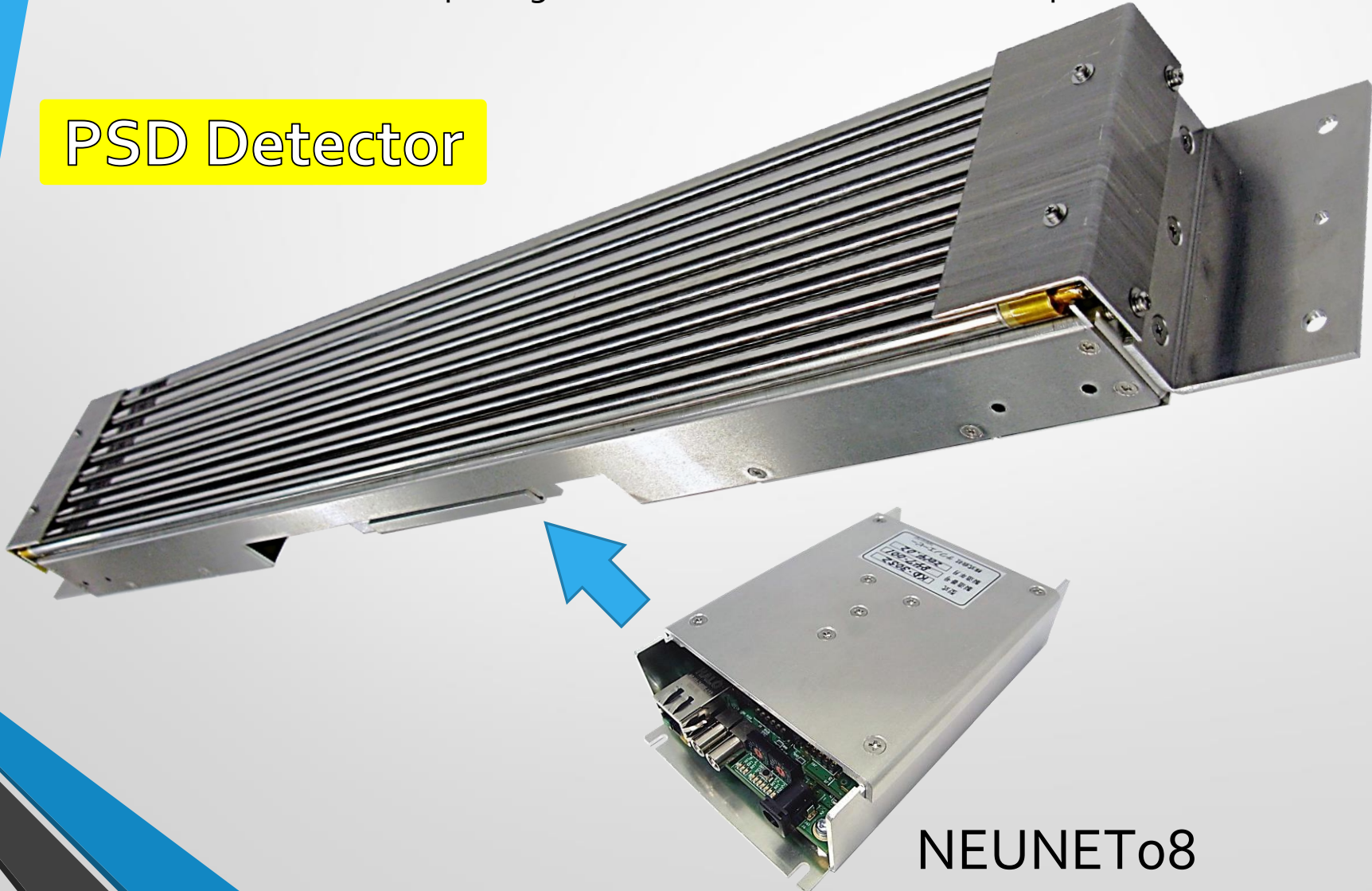
This data handling board is used for this **NEUNET** system.

NUENET

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Analog Digital Convertor Processing and Data Processing board
for Output signal of ^3He Position Sensitive Proportional Counter

PSD Detector



NEUNETo8

ITEM	SPECIFICATION
Product Name / Model	Date processing board for Neutron / Model: KD-3052
Analog Input Signal	Differential Signal, Negative Unipolar Pulse, 0 ~ -1.0V *Input impedance: 100Ω
To Input Signal	TTL / Positive Logic Pulse, Input Impedance: 1kΩ Pulse Width: > 0ns, Rise Time: > 20ns
Input Connector	Connector for Power Supply: DC Plug φ5.5 x φ2.1 Connector for To signal: LEMO 00 type Connector for Analog signal: HIF3BA-26PA-2.54DS *MIL Standard
External Dimensions	150(W) x 93(D) x 38(H) *Storable to the PSD detector box of 1/2 inch x 600 x 8 tubes
Power Supply	Operating by power supply of the board: 5V / 2.2A *AMP97 and PSD detector board are used by In-house product Another Power Supply Setting: ±12V, ±5V, 3.3V, 1.8V, 1.2V
Environmental Condition	Temperature: 0~50° C Maximum humidity: 80% (No dew condensation)

[Business lineup]

- (1) Sales of radiation measuring instrument and radiation counter.
- (2) Development of radiation measuring device and radiation counter.
- (3) Development of research and development device, measurement controlling system, and inspection apparatus.

[Contact]



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ご訪問によるご提案やデモ等

随時受け付けております。

是非お気軽にご相談ください。

皆様のご期待に沿えるよう

一意専心努力してまいりますので

これからも末永くご支援賜りますよう

お願い申し上げます。

何かお役に立てることがございましたら

ご遠慮なくご連絡ください。

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日本

SPring-8

大型放射光施設

Mt. Fuji

富士山

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日本原子力開発機構

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KEK, AIST

高エネルギー加速器研究機構
産業技術総合研究所

Narita Airport

成田国際空港